

# 20V N-Channel Trench MOSFET(Preliminary)

## **General Description**

- Trench Power technology
- Low R<sub>DS(ON)</sub>
- Low Gate Charge
- Optimized for fast-switching applications

### **Applications**

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

#### **Product Summary**

 $V_{DS}$  20V  $I_{D}$  (at  $V_{GS} = 10V$ ) 150A

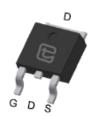
 $R_{DS(ON)}$  (at  $V_{GS} = 10V$ ) < 2.8m $\Omega$ 

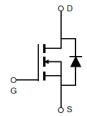
$$\begin{split} R_{DS(ON)} & \text{ (at $V_{GS}$ = 4.5V)} & < 3.0 \text{m} \Omega \\ R_{DS(ON)} & \text{ (at $V_{GS}$ = 2.5V)} & < 4.4 \text{m} \Omega \end{split}$$

100% UIS Tested



TO-252





Part Number	Package Type	Form	Marking
TTD150N02GT	TO-252	Tape&Reel	150N02GT

# Absolute Maximum Ratings (T<sub>A</sub> =25°C unless otherwise noted)

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V <sub>DS</sub>	20	V	
Gate-Source Voltage		V <sub>GS</sub>	±20	V	
Ocation of David Comment B	T <sub>C</sub> =25°C		46	Δ.	
Continuous Drain Current B	T <sub>C</sub> =100°C	I <sub>D</sub>	46	А	
Pulsed Drain Current <sup>A</sup>		I <sub>DM</sub>	450	Α	
Avalanche Current <sup>A</sup>		I <sub>AS</sub>	32	А	
Single Pulse Avalanche Energy L =0.3mH A		E <sub>AS</sub>	153.6	mJ	
Dawer Dissipation C	T <sub>C</sub> =25°C	Б	127	W	
Power Dissipation <sup>C</sup>	T <sub>C</sub> =100°C	P <sub>D</sub>	63.6	W	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C	

#### Thermal Characteristics

Parameter		Symbol	Maximum	Units
Maximum Junction-to-Case	Steady-State	$R_{\Theta JC}$	1.18	00.444
Maximum Junction-to-Ambient	Steady-State	R <sub>eJA</sub>	100	°C/W



Symbol	Parameter	Conditions		Value			110:4-
Зуппоот	Parameter Conditions			Min	Тур	Max	Units
STATIC P	ARAMETERS					_	
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		20			V
		$V_{DS} = 20V, V_{GS} = 0V$ $T_{J} = 25^{\circ}C$ $T_{J} = 100^{\circ}C$			1		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current		T <sub>J</sub> =100°C			25	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	,			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		0.5	0.7	1.2	V
		V <sub>GS</sub> =10V, I <sub>D</sub> =30A			2.2	2.8	mΩ
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =30A			2.3	3.0	mΩ
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =30A			3.4	44	mΩ
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =20A			21		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =46A, V <sub>GS</sub> =0V				1	V
I <sub>s</sub>	Maximum Body-Diode Continuous Current B				46	Α	
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance				6073		
C <sub>oss</sub>	Output Capacitance	$V_{GS} = 0V, V_{DS} = 10V, f = 1MH_Z$			1540		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				1171		
SWITCHIN	IG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge	$V_{GS} = 10V, V_{DS} = 10V, I_{D} = 50A$			165		
$Q_{gs}$	Gate Source Charge				9		nC
$Q_{gd}$	Gate Drain Charge				30		
t <sub>D(on)</sub>	Turn-On Delay Time	$V_{GS} = 10V, V_{DS} = 10V, I_{D} = 50A,$ $R_{G} = 3\Omega$			13		
t <sub>r</sub>	Turn-On Rise Time				17		ns
$T_{D(off)}$	Turn-Off Delay Time				19		
t <sub>f</sub>	Turn-Off Fall Time				16		
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I 504 JUL 4001			17		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =50A, di/dt =100A/μs			15		nC

- A. Single pulse width limited by maximum junction temperature.
- B. The maximum current rating is package limited.
- C. The power dissipation  $P_D$  is based on  $T_{J(MAX)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

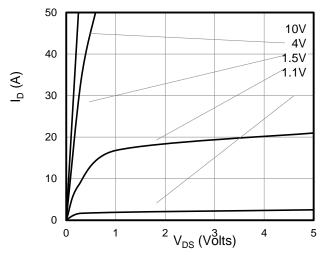


Figure 1: On-Region Characteristics

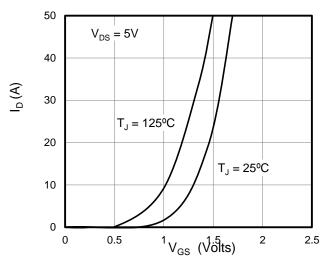


Figure 2: Transfer Characteristics

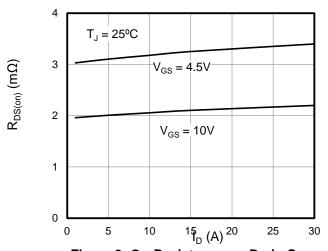


Figure 3: On-Resistance vs. Drain Current

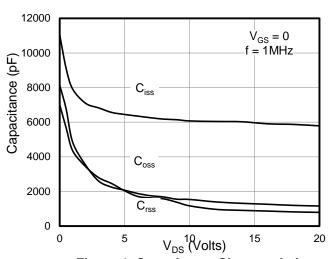


Figure 4: Capacitance Characteristics

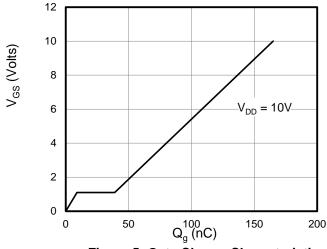


Figure 5: Gate Charge Characteristics

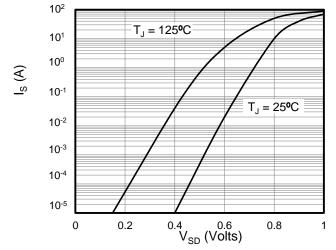


Figure 6: Body Diode Forward Voltage

 $Z_{\theta, JC}$  Normalized Transient Thermal Resistance

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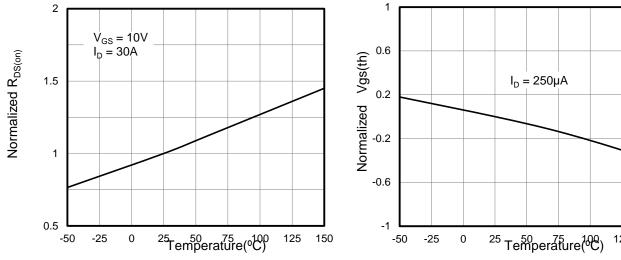


Figure 7: On-Resistance vs. Junction Temperature

Figure 8: Vgs(th) vs. Junction Temperature

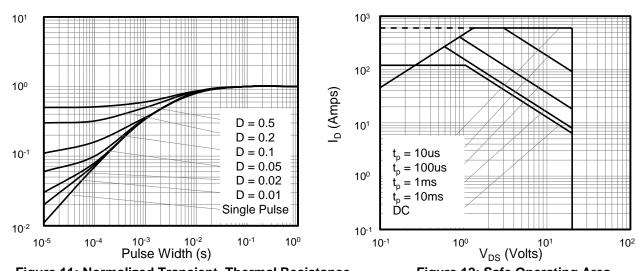


Figure 11: Normalized Transient Thermal Resistance

Figure 12: Safe Operating Area

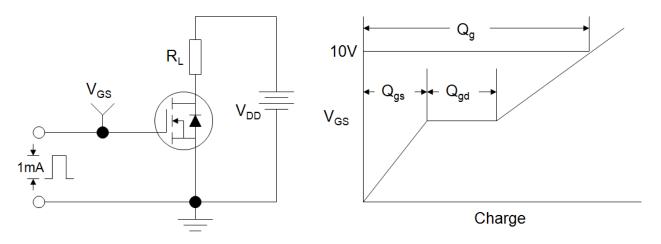


Figure A: Gate Charge Test Circuit and Waveforms

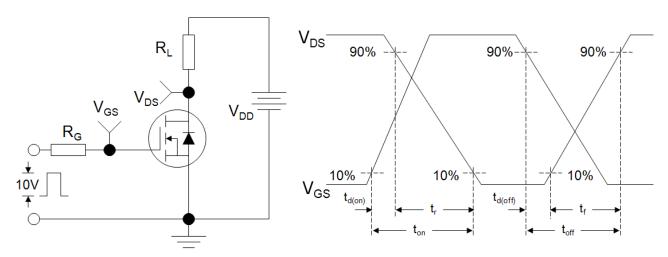


Figure B: Resistive Switching Test Circuit and Waveforms

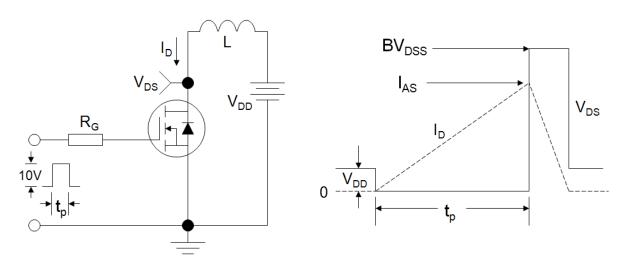
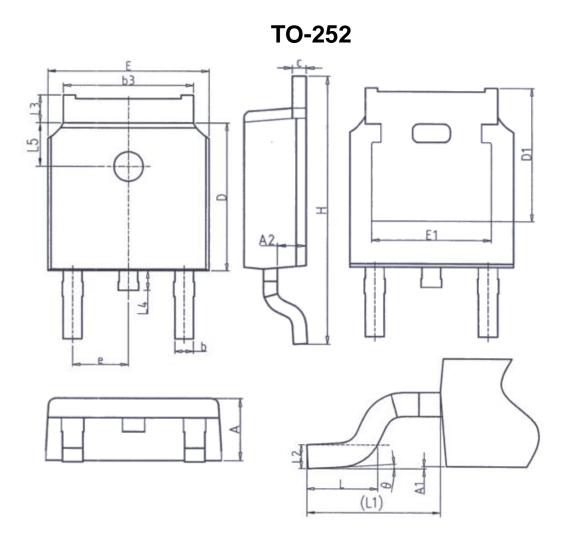


Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms





Unit: mm			
Symbol	Min.	Max.	
Α	2. 20	2. 40	
A1	0.00	0. 20	
A2	0. 97	1. 17	
b	0. 68	0. 90	
b3	5. 20	5. 50	
С	0. 43	0. 63	
D	5. 98	6. 22	
D1 5. 30REF			
E	6. 40	6. 80	
E1	4. 63	_	

Unit: mm			
Symbol	Min.	Max.	
е	2. 286BSC		
Н	9. 40	10.50	
L	1. 38	1. 75	
L1	2. 90REF		
L2	0. 51BSC		
L3	0.88	1. 28	
L4	_	1.00	
L5	1. 65	1. 95	
θ	0°	8°	



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